

Search Notes

Application/Control No.

10/021,224

Examiner

Brian J. Detwiler

Applicant(s)/Patent under
Reexamination

AN CHANG ET AL.

Art Unit

2173

SEARCHED

Class	Subclass	Date	Examiner
715	757	4/12/2005	BD
	764		
	765		
	782		
	810		
	836		
	848		
	849		
	852		
	853		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST and NPL Internet searches for: scheme, theme, object, image, data, sort, arrange, 3D, metadata.	4/14/2005	BD